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August 2014

# FDM3622

# N-Channel PowerTrench® MOSFET

100V, 4.4A, 60mΩ

# **Features**

- Max  $r_{DS(on)} = 60m\Omega$  at  $V_{GS} = 10V$ ,  $I_D = 4.4A$
- Max  $r_{DS(on)} = 80m\Omega$  at  $V_{GS} = 6.0V$ ,  $I_D = 3.8A$
- Low Miller Charge
- Low QRR Body Diode
- Optimized efficiency at high frequencies
- UIS Capability (Single Pulse and Repetitive Pulse)
- RoHS Compliant

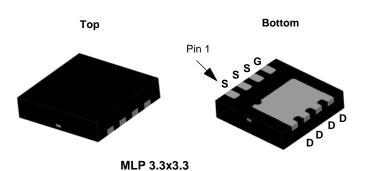


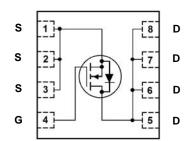
# **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

# **Applications**

- Distributed Power Architectures and VRMs.
- Primary Switch for 24V and 48V Systems
- High Voltage Synchronous Rectifier
- Formerly developmental type 82744





# MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
$V_{DS}$	Drain to Source Voltage		100	V
$V_{GS}$	Gate to Source Voltage		±20	V
	Drain Current -Continuous	(Note 1a)	4.4	^
'D	-Pulsed		20	Α
Eas	Single Pulse Avalanche Energy	(Note 3)	54	mJ
В	Power Dissipation	(Note 1a)	2.1	W
$P_{D}$	Power Dissipation	(Note 1b)	0.9	VV
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

## **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	3.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	60	C/VV

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDM3622	FDM3622	MLP 3.3x3.3	13"	12 mm	3000 units

# **Electrical Characteristics** $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
	Zero Gate Voltage Drain Current	$V_{DS} = 80V, V_{GS} = 0V$			1	μА
IDSS	Zero Gate Voltage Drain Gurrent	T <sub>J</sub> = 100°C			250	μΛ
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 20V$ , $V_{DS} = 0V$			±100	nA

### On Characteristics

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2		4	V
		$V_{GS} = 10V, I_D = 4.4A$		44	60	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 6.0V, I_D = 3.8A$		56	80	$m\Omega$
		$V_{GS} = 10V, I_D = 4.4A, T_J = 150°C$		92	120	

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V, f = 1MHz		820	1090	pF
C <sub>oss</sub>	Output Capacitance			125	170	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			35	55	pF
Rg	Gate Resistance	$V_{DS} = 15 \text{mV}, f = 1 \text{MHz}$	0.1	3.1	6.2	Ω

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		11	20	ns
t <sub>r</sub>	Rise Time	$V_{DD} = 50V, I_D = 4.4A$ $V_{GS} = 10V, R_{GEN} = 24\Omega$	25	40	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 2402$	35	56	ns
t <sub>f</sub>	Fall Time		26	42	ns
$Q_g$	Total Gate Charge	V <sub>GS</sub> = 10V	13	17	nC
$Q_{gs}$	Gate to Source Gate Charge	$V_{DD} = 50V$	3.6		nC
$Q_{gd}$	Gate to Drain "Miller" Charge	I <sub>D</sub> = 4.4A	3.4		nC

# **Drain-Source Diode Characteristics**

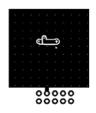
$V_{SD}$	1 Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 4.4A$		1.25	V
		$V_{GS} = 0V, I_{S} = 2.2A$		1.0	V
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 4.4A$ , di/dt = 100A/ $\mu$ s		56	ns
Q <sub>rr</sub>	Reverse Recovery Charge			108	nC

Notes:

1. R<sub>BJA</sub> is determined with the device mounted on a 1 in<sup>2</sup> oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>BJC</sub> is guaranteed by design while R<sub>BJA</sub> is determined by the user's board design.

(a)R<sub>BJA</sub> = 60°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper, 1.5'x1.5'x0.062' thick PCB.

(b)R<sub>BJA</sub> = 135°C/W when mounted on a minimum pad of 2 oz copper.



a. 60°C/W when mounted on a1in<sup>2</sup>pad of 2 oz copper



b. 135°C/W when mounted on a minimum pad of 2 oz copper

- 2: Pulse Test: Pulse Width <  $300\,\mu$ s, Duty cycle < 2.0%. 3: E<sub>AS</sub> of 54 mJ is based on starting T<sub>J</sub> = 25 C; N-ch: L = 3 mH, I<sub>AS</sub> = 6 A, V<sub>DD</sub> = 100 V, V<sub>GS</sub>= 10 V.

# **Typical Characteristics** $T_J = 25$ °C unless otherwise noted

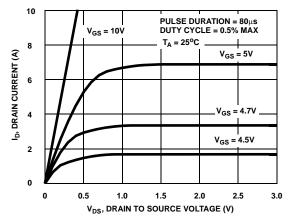


Figure 1. On-Region Characteristics

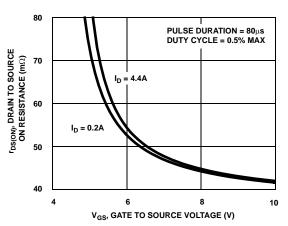


Figure 3. On-Resistance vs Gate to Source Voltage

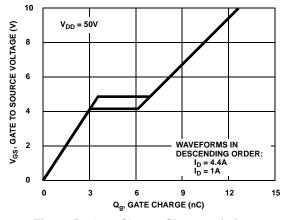


Figure 5. Gate Charge Characteristics

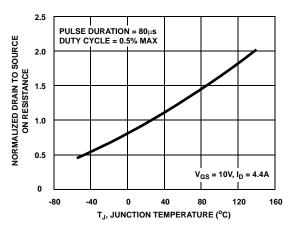


Figure 2. Normalized On-Resistance vs Junction Temperature

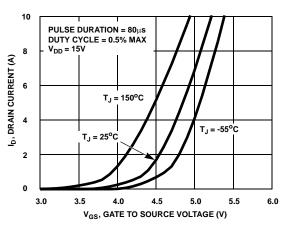


Figure 4. Transfer Characteristics

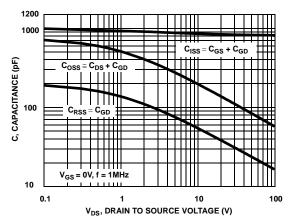


Figure 6. Capacitance vs Drain to Source Voltage

# Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

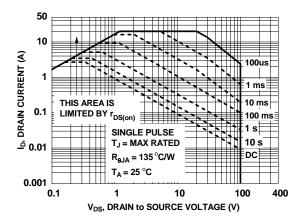


Figure 7. Forward Bias Safe Operating Area

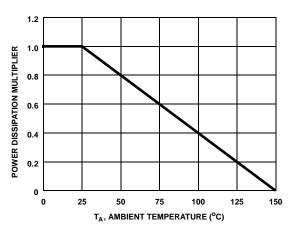


Figure 9. Normalized Power dissipation vs Ambient Temperature

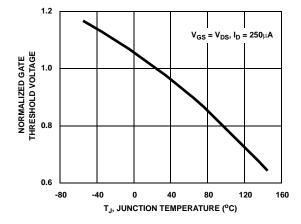


Figure 11. Normalized Gate Threshold voltage vs Junction Temperature

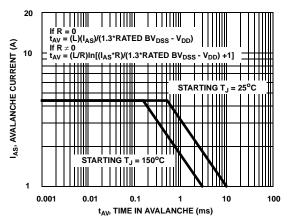


Figure 8. Uncalamped Inductive Switching Capability

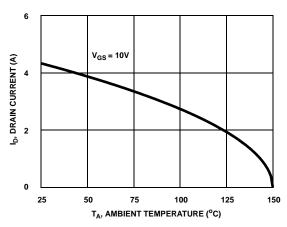


Figure 10. Maximum Continuous Drain Current vs Ambient Temperature

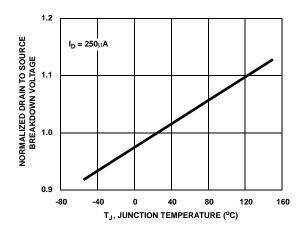


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

# Typical Characteristics $T_J = 25^{\circ}\text{C}$ unless otherwise noted

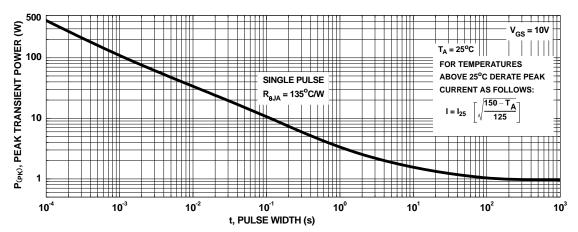


Figure 13. Peak Current Capability

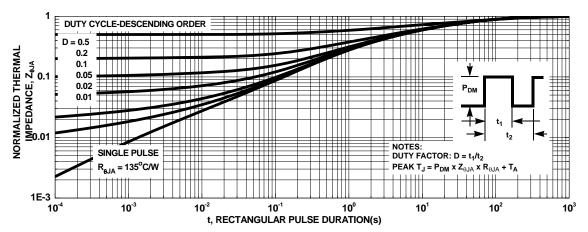
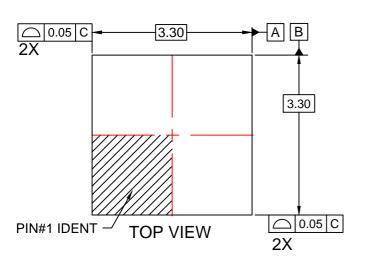
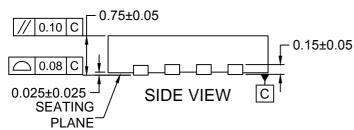
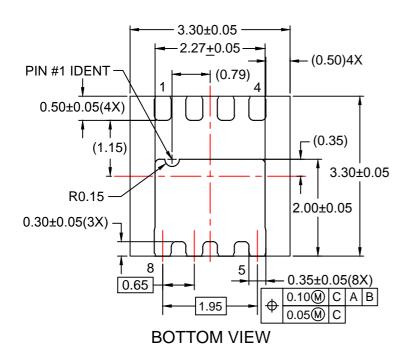
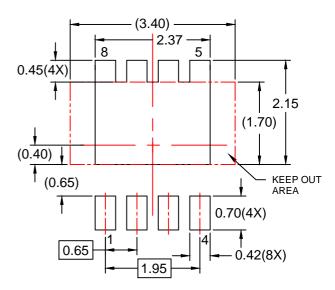


Figure 14. Transient Thermal Response Curve









RECOMMENDED LAND PATTERN

# NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-MLP08Srev3.



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